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# Phase Transition in Tl<sub>2</sub>TeO<sub>4</sub>

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Abstract. A polycrystalline sample of thallium telurate,  $Tl_2TeO_4$ , was prepared by a solid-state reaction technique. Preliminary X-ray structural study of the compound reveals the formation of single phase orthorhombic compound at room temperature. Detailed studies of dielectric constant as function of temperature and frequency suggest that the compound undergoes two phase transitions at 3°C and 272°C. Variation of dc resistivity with temperature shows that the conductivity of the material increases with the rise in temperature.

Keywords: dielectrics, incommensurate-commensurate phase transition, orthorhombic structure

### 1. Introduction

Since the discovery of successive or multiple phase transitions in BaTiO<sub>3</sub> in 1945, a large number of simple or complex compounds of different structural families have been examined in the past, but no compound with this type of phase transitions have been found so far. However, in last decade, ferroelectric properties with different types of successive phase transition (i.e., commensurate-incommensurate) in Rb<sub>2</sub>ZnCl<sub>4</sub> [1] was observed. This compound with  $K_2SO_4$  type structure, undergoes successive phase transition from a high-temperature normal phase (I) to a ferroelectric commensurate phase (III) via the incommensurate modulated phase (II) [2–5]. A normal phase belongs to the orthorhombic system with space group Pmcn. In the incommensurate phase, crystal lattice is modulated along c-axis with wave vector  $q = (1/3 - \delta)c_o^*$  where  $c_o^* =$  reciprocal unit parameter in the normal phase. The cell ferroelectric phase is caused by locking into a commensurate value ( $\delta = 0$ ) of  $q = 1/3c_o^*$ . The space group of ferroelectric phase is  $P2_1cn$  and spontaneous polarization develops along b-axis [6-7]. This type of sequence phase transition was observed in a few compounds of A2BX4

(A = monovalent ions,  $BX_4$  = divalent tetrahedral complex such as  $SeO_4^{-2}$ ,  $ZnCI_4^{-2}$ , X = CI, Br, I) family. Therefore, in order to check the existence of successive phase transitions with the above characteristics we have carried out preliminary structural and detailed dielectric and spectroscopic investigations of the  $A^{2+}{}_2B^{6+}O^{2-}{}_4$  (B = S, W, Mo, Te, Se) compounds. In this paper, we report phase transition in the  $TI_2TeO_4$  compound, on which not much work has been reported so far.

# 2. Experimental Details

The polycrystalline  $Tl_2TeO_4$  compound was prepared by a solid-state reaction technique using raw materials, thallium carbonate  $Tl_2CO_3$  (99.9% M/s Aldrich Chemical Co. Inc) and tellurium  $TeO_2$  oxide in an air atmosphere. These materials were thoroughly mixed in an agate mortar for 2 h. The mixed powder was calcined in an air atmosphere at 873 K for 5 h. The calcined powder was grounded and recalcined at 873 K for 6 h. The finally recalcined fine powder was used to make pellets of 10 mm diameter and 1–2 mm thickness under a pressure of  $6 \times 10^7$  Kg/m<sup>2</sup> using a hydrolic press. Polyvinyl alcohol (PVC) was used as a binder which was burnt out during sintering. The pellets were then sintered at 900° K for 4 h in an alumina crucible to reduce the porosity of the green pellets. The formation of single phase  $Tl_2TeO_4$  compound was checked by X-ray diffraction (XRD) technique.

For the preliminary structural studies, X-ray powder diffractogram (XRD) of the compound was recorded at room temperature with a X-ray diffractometer (Rikagu, Japan) with  $CuK_{\alpha}$  radiation  $(\lambda = 1.5418 \text{\AA})$  in a wide ranges of Bragg angles  $2\theta$  $(20^{\circ} \le 2\theta \le 100^{\circ})$  at a scanning rate of 2°/min. The dielectric constant ( $\varepsilon$ ) and loss tangent (tan  $\delta$ ) of the compound were measured as a function of frequency  $(400 \text{ Hz to } 10^4 \text{ kHz})$  at room temperature and as a function of temperature (-150 to  $400^{\circ}$ C) at a fixed frequency of 10 kHz over a small temperature interval using a GR 1620 AP capacitance measuring assembly in conjunction with a laboratory-made three-terminal sample holder which compensated any stray capacitance. As the dielectric loss  $(\tan \delta)$  was becoming very high at lower frequencies with rise in temperature, all the dielectric measurements were conducted only at 10 kHz (i.e., maximum limit of our GR Bridge). As the purpose of our measurements (i.e., to detect phase transition) was limited, this measurement at higher frequency was not conducted. The temperatures were measured using a chromel-alumel thermo-couple. The dc volume resistivity of the pellet sample was measured as a function of electric field at room temperature and as a function of temperature at a constant electric field using a Keithley-617 programmable electrometer. The temperature of the sample was recorded using chromel alumel thermocouple with an accuracy of  $+2^{\circ}$ C.

### 3. Results and Discussion

The sharp and single peaks of XRD pattern showed the formation of single crystalline phase compound. All the high, medium and low intensity and angle peaks were indexed in different (unit) cell configurations and crystal systems with the help of a standard computer program package (POWDIN). Finally, a suitable unit cell was selected on the basis of the best agreement in observed and calculated d values. The selected cell parameters were refined by least-squares method. These are:  $a = 10.562(1)\text{\AA}$ ,  $b = 8.700(1)\text{\AA}$  and  $c = 9.794(1)\text{\AA}$ . A good agreement found between

observed and calculated *d*-values (Table 1) suggests that the material has orthorhombic crystal structure at room temperature. However, with the limited number of reflections and crystal data it was not possible to uniquely determine the exact space/point group of the compound. The coherently scattered particle size of the pellet sample was calculated from each XRD reflection using Scherrer's equation:  $P = K\lambda/\beta_{1/2}$  $\cos \theta_{hkl}$  where *K* is an arbitrary constant with best possible values of 0.89,  $\beta_{1/2}$  is the half peak width for each hkl reflection and  $\theta_{hkl}$  is its Bragg angle. The average value of this particle size was 280Å

At room temperature frequency dependence of dielectric constant ( $\varepsilon$ ) and loss tangent (tan  $\delta$ ) of the material is shown in Fig. 1. Decrease of  $\varepsilon$  and tan  $\delta$ with increase of frequency is noted as a normal dielectric behavior of  $Tl_2TeO_4$ . The variation of  $\varepsilon$  and tan  $\delta$  of the compound with temperature (  $-150^{\circ}$ C to 400°C) is shown in Fig. 2. A dielectric anomaly was observed between 12°C and 15°C, with maximum  $\varepsilon_{\text{max 1}}$  at  $T_i = 13^{\circ}$ C, and again another between 271°C and 275°C ( $\varepsilon_{\text{max}}$  at 273°C).  $T_1$  corresponds to the transition temperature  $(T_C)$  from the ferroelectric phase (commensurate) to the incommensurate phase and  $T_2$  corresponds to the transition temperature  $(T_c)$ from incommensurate to the normal paraelectric phase as compared to the sequential phase transitions of the other members of A2BX4 family. The first phase transition is sharper than the second one. At higher temperatures (above  $T_i$ ), increase of  $\varepsilon$  and tan  $\delta$  with temperature was found falling only over a short range of temperature, and then increases rapidly with rise in temperature. The increase in  $\varepsilon$  at this stage may be due to the space charge polarization as observed in other ceramic samples [8,9]. This extraordinary situation makes it difficult to accurately infer if the phase transition about  $T_i$  has any amount of relaxation. Even with a poled sample, it was not possible to obtain a proper hysterisis loops as a function of temperature. As a result, it was not possible to conclude experimentally, the commensurate-incommensurate phase transitions in the compound. However, by anology with other compounds of the family, it is suggested that this compound also has sequential/successive commensurate-incommensurate phase transition. A single crystal work is planned to confirm this feature.

An electrical conductivity  $\sigma_{ac}$  was calculated from the relation  $\sigma_{ac} = \omega \varepsilon_0 \varepsilon \tan \delta$  at different temperatures where  $\omega$  = angular frequency,  $\varepsilon$  = relative

Table 1. Comparison of some observed and calculated d-values (inÅ) of some reflections of Tl<sub>2</sub>TeO<sub>4</sub> at room temperature

|      |                    |                    | T / T            |
|------|--------------------|--------------------|------------------|
| hkl  | $d_{\rm obs}$ (A°) | $d_{\rm cal}$ (A°) | I/I <sub>o</sub> |
| 120  | 4.0224             | 4.0224             | 22               |
| 300  | 3.5208             | 3.5208             | 30               |
| 024  | 3.2672             | 3.2672             | 40               |
| 205  | 3.1646             | 3.1676             | 10               |
| 016  | 3.0792             | 3.0847             | 20               |
| 215  | 2.9689             | 2.9765             | 40               |
| 125  | 2.8227             | 2.8215             | 100              |
| 026  | 2.6292             | 2.6286             | 60               |
| 008  | 2.4747             | 2.4742             | 40               |
| 035  | 2.3442             | 2.3395             | 35               |
| 041  | 2.1611             | 2.1621             | 12               |
| 501  | 2.1034             | 2.1006             | 16               |
| 430  | 1.9531             | 1.9525             | 17               |
| 145  | 1.8770             | 1.8876             | 10               |
| 336  | 1.8520             | 1.8523             | 12               |
| 343  | 1.7809             | 1.7817             | 40               |
| 0111 | 1.7618             | 1.7621             | 30               |
| 3110 | 1.6924             | 1.6924             | 20               |
| 517  | 1.6612             | 1.6612             | 08               |
| 0112 | 1.6208             | 1.6206             | 09               |
| 509  | 1.5235             | 1.5235             | 11               |



Fig. 1. Variation of dielectric constant ( $\epsilon$ ) and loss (tan  $\delta$ ) of Tl<sub>2</sub>TeO<sub>4</sub> with frequency (f) at room temperature.



Fig. 2. Variation of dielectric constant ( $\epsilon$ ) and loss (tan  $\delta$ ) of Tl<sub>2</sub>TeO<sub>4</sub> with temperature at 10 kHz.

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permittivity of the sample, and  $\varepsilon_0 = \text{dielectric}$ permittivity in free space. In  $\sigma_{ac}Vs \cdot T^{-1}$  (°K) plot is shown in Fig. 3(A) and 3(B) for higher and lower temperature ranges  $30^{\circ}$ C to  $394^{\circ}$ C and  $-70^{\circ}$ C to 25°C, respectively. The anomaly in the plot of Fig. 3(A) was obtained at the temperature 282°C which is slightly higher, but corresponds to second phase transition temperature. Above 315°C space charge polarization can easily be seen in this figure. An anomaly in  $\sigma_{ac}$  (Fig. 3(B)) is observed near the first transition temperature  $(T_1 = T_c)$ . In  $\sigma_{ac}$  decreases linearly with  $T^{-1}$  in temperature range of 30°C to 118°C (Fig. 3(A)). It follows, therefore, that in this region the activation energy  $(E_a)$  remains almost constant (0.21 eV). In the temperature range of 118°C to 282°C, the non-linear decrease of  $\ln\sigma$  with inverse of temperature and the slope of the curve slowly increasing with decreasing  $T^{-1}$  indicating the gradual march of the electrical property of the material towards the ferroelectric phase with the activation energy increasing with the increase of temperature. The calculated values of  $E_a$  near 227°C and 357°C were 0.52 and 0.63 eV respectively. As the calculation



*Fig. 3A.* Variation of ac conductivity  $(\ln \sigma)$  of  $TI_2Te0_4$  with inverse of absolute temperature (1/T) from  $(30^{\circ}C \text{ to } 394^{\circ}C)$  at 10 kHz.



*Fig. 3B.* Variation of ac conductivity  $(\ln \sigma)$  of TI<sub>2</sub>TeO<sub>4</sub> with inverse of absolute temperature (1/T) from  $(-70^{\circ} \text{ to } 25^{\circ}\text{C})$  at 10 kHz.

of  $E_a$  at low temperature is not important, we have not calculated it from Fig. 3(B).

At room temperature variation of dc resistivity with biasing field (V/cm) is shown in Fig. 4 where  $\ln \rho_{dc}$  has been plotted against the biasing electric field. It is observed that the resistivity of the material decreases with increasing baising field as reported and explained earlier in other ferroelectric compounds [6,10].



*Fig.* 4. Variation of dc resistivity  $(\ln \sigma)$  of  $Tl_2TeO_4$  with applied electric field at room temperature.

Temperature dependence of dc resistivity ( $\rho_{dc}$ ) of the material at constant biasing (10 V/cm) fields is shown in Fig. 5. It is interesting to note that at higher temperatures (above 145°C),  $\rho_{dc}$  decreases with the increase of temperature. This may be due to more supply of thermal energy to the material leading to the creation of more and more free electrons. Between 95°C to 130°C,  $\rho_{dc}$  of the material does not vary by more than 2%. This indicates that a very few thermally generated free electrons are created in this range of temperature. In the low temperature range (below 110°C),  $\rho_{dc}$  decreases as the temperature decreases. Similar temperature dependence property of  $\rho_{\rm dc}$  was observed in the Rb<sub>2</sub>TeO<sub>4</sub> compound. In the low temperature regions both Tl<sub>2</sub>TeO<sub>4</sub> and Rb<sub>2</sub>TeO<sub>4</sub> exhibit sharp increase in conductivity with rise in temperature. The calculated values of  $E_a$  in the high temperature region (Fig. 5) was about 0.5 eV.

Finally, it is concluded that  $Tl_2TeO_4$  has orthorhombic structure at room temperature with successive



*Fig.* 5. Variation of dc resistivity  $(\ln \sigma)$  of Tl<sub>2</sub>TeO<sub>4</sub> with inverse of absolute temperature (1/T).

phase transitions on cooling from elevated temperature. The first transition probably belongs to a ferroelectric to incommensurate change, the second to a change from incommensurate to normal ferroelectric phase, and in this phase the material has an increasing conductivity with decrease in temperature.

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#### References

- 1. K. Gesi and M. Iizumi, J. of Phy. Soc. of Japan, 53, 4271 (1984).
- K. Deguchi, Y. Okada, and E. Nakamura, J. of Phy. Soc. of Japan, 56, 208 (1987).
- H. Masahiyama, H. Suzuki, F. Shimizu, T. Yamaguchi, and S. Sawada, J. of Phy. Soc. of Japan, 59, 3479 (1990).
- M. Wada, A. Sawada, and Y. Ishibashi, J. of Phy. Soc. of Japan, 47, 4 (1979).
- 5. F. Shimizu, T. Anzai, M. Takashige, and S. Sawada, *Ferroelectrics*, **168**, 215 (1995).
- 6. K. Gesi, J. of Phy. Soc. of Japan, 53, 3850 (1984).
- N. Yamada, Y. Ono, and T. Ikeda, J. of Phy. Soc. of Japan, 53, 2565 (1984).
- S. Sharma, R. Sati, and R.N.P. Choudhary, J. of Mat. Sc. Letters (U.K.), 13, 1151 (1994).
- S. Sharma, R.N.P. Choudhary, and R. Sati, J. of Mat. Sc. Letters (U.K.), 12, 530 (1993).
- R.N.P. Choudhary, M.L.N. Goswami, and S. Sharma, *Indian J. Phys.*, **71A**, 153 (1997).